

# NPC

## 5041 series

High-stability Crystal Oscillator IC with Frequency Adjustment Function

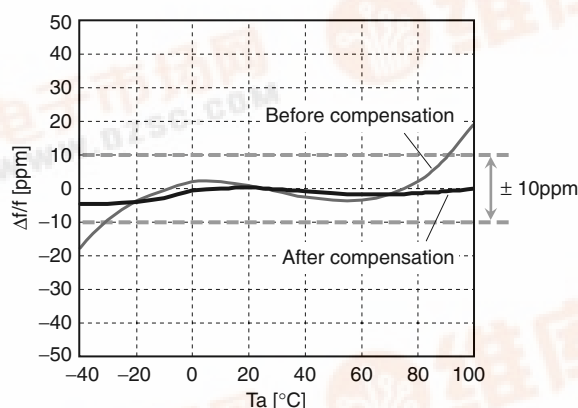
### OVERVIEW

The 5041 series are high-stability clock oscillator ICs with built-in frequency adjustment functions. The frequency adjustment functions can be optimized, by the addition of a minimal adjustment process, to improve the frequency stability. The function is implemented using frequency adjustment data written to a built-in EEPROM over a 1-wire serial interface. The ICs are ideal for compact crystal oscillators for use in applications such as WiMAX (Worldwide Interoperability for Microwave Access) and PLC (Power Line Communication) that require high frequency stability in the order of  $\pm 30$  to  $\pm 10$ ppm. They use a pad layout suitable for flip chip bonding mounting.

### FEATURES

- Realizing frequency stability improvement with minimal additional process
- Temperature compensation range/ operating temperature range:  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$
- Frequency adjustment functions built-in
  - Frequency-temperature characteristics compensation function
  - AT-cut crystal, 3rd order harmonic frequency-temperature characteristics compensation, with independent low-temperature and high-temperature range compensation settings
    - Center frequency adjustment function
    - Temperature rotation compensation function
    - Low-temperature characteristics compensation
    - High-temperature characteristics compensation
- Rewritable EEPROM built-in
- 6 pads: same as general clock oscillator ICs
- Operating supply voltage range
  - 5041A $\times\times$ : 2.25V to 3.63V
  - 5041B $\times$ A: 1.60V to 2.25V
- Recommended oscillation frequency range: 20MHz to 55MHz (for fundamental oscillation)
- Frequency divider built-in:
  - Selectable by version:  $f_O$ ,  $f_O/2$ ,  $f_O/4$ ,  $f_O/8$ ,  $f_O/16$ ,  $f_O/32$
  - Frequency divider output for 0.625MHz (min) low frequency output
- Standby function
- High-impedance in standby mode, oscillator stops
- CMOS output
- 15pF output load
- Pad layout for flip chip bonding
- Wafer form (WF5041 $\times\times\times$ )

### FREQUENCY CHARACTERISTICS COMPENSATION BEFORE and AFTER ADJUSTMENT



### APPLICATIONS

- 3.2mm  $\times$  2.5mm, 2.5mm  $\times$  2.0mm, 2.0mm  $\times$  1.6mm size miniature crystal oscillator modules
- WiMAX, WiBro, PLC and applications requiring high-stability clock oscillators

### ORDERING INFORMATION

| Device                         | Package    |
|--------------------------------|------------|
| WF5041 $\times\times\times$ -4 | Wafer form |

## SERIES CONFIGURATION

| Pad layout            | Recommended oscillation frequency range <sup>*1</sup> [MHz] | Operating supply voltage range [V] | Temperature adjustment function gain setting ratio <sup>*2</sup> | Output frequency and version name <sup>*3</sup> |           |           |           |           |           |
|-----------------------|---|------------------------------------|--|---|-----------|-----------|-----------|-----------|-----------|
|                       |   |                                    |  | $f_0$   | $f_0/2$   | $f_0/4$   | $f_0/8$   | $f_0/16$  | $f_0/32$  |
| for flip chip bonding | 20 to 55  | 2.25 to 3.63                       | 1  | 5041A1A   | 5041A2A   | 5041A3A   | 5041A4A   | 5041A5A   | 5041A6A   |
|                       |   |                                    | 2  | 5041A1B   | 5041A2B   | 5041A3B   | 5041A4B   | 5041A5B   | 5041A6B   |
|                       |   | 1.60 to 2.25                       | (1)  | (5041B1A)                                       | (5041B2A) | (5041B3A) | (5041B4A) | (5041B5A) | (5041B6A) |

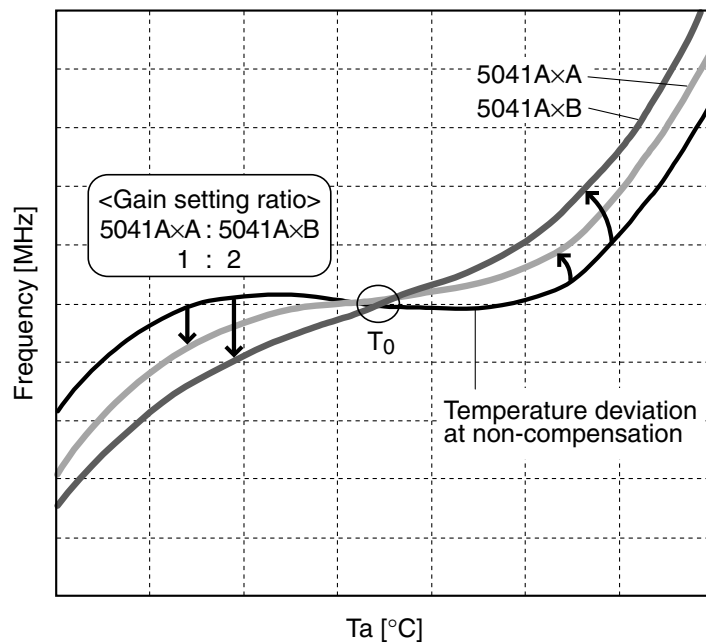
\*1. The recommended oscillation frequency is a yardstick value derived from the crystal used for NPC characteristics authentication. However, the oscillation frequency range is not guaranteed. Specifically, the characteristics can vary greatly due to crystal characteristics and mounting conditions, so the oscillation characteristics of components must be carefully evaluated.

\*2. Values in parentheses ( ) are provisional only.

\*3. Versions in parentheses ( ) are under development.

## TEMPERATURE ADJUSTMENT FUNCTION GAIN SETTING RATIO

Temperature adjustment function gain setting ratio of 5041A×A and 5041A×B differs. In the case of temperature adjustment function that rotates temperature characteristics on  $T_0$  origin, adjustment sensitivity of 5041A×B is designed twice as higher than that of 5041A×A based on non-compensation temperature deviation in same register value setting.

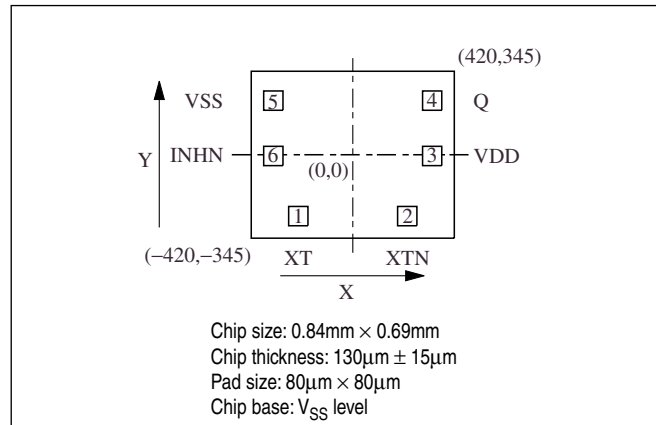


## VERSION NAME

| Device      | Package    | Version name   |
|-------------|------------|--|
| WF5041xxx-4 | Wafer form | <p>WF5041□□□-4</p> <p>Form WF: Wafer form</p> <p>Temperature adjustment function gain setting ratio</p> <p>Frequency divider function (output frequency)</p> <p>Operating supply voltage</p> |

## PAD LAYOUT

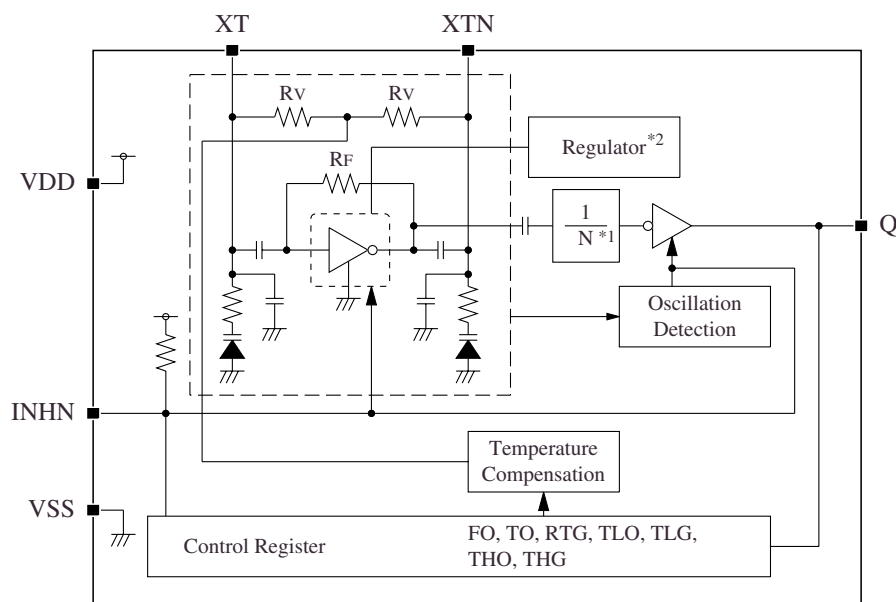
(Unit:  $\mu\text{m}$ )



## PAD DIMENSIONS PIN DESCRIPTION

| Pad No. | Pin | I/O | Name                       | Description   | Pad dimensions [ $\mu\text{m}$ ] |        |
|---------|-----|-----|----------------------------|---|----------------------------------|--------|
|         |     |     |                            |   | X                                | Y      |
| 1       | XT  | I   | Amplifier input            | Crystal connection pins.<br>Crystal is connected between XT and XTN.  | -225.2                           | -253.5 |
| 2       | XTN | O   | Amplifier output           |   | 225.2                            | -253.5 |
| 3       | VDD | -   | (+) supply voltage         | -   | 328.5                            | -5.0   |
| 4       | Q   | O   | Output                     | Output frequency determined by internal circuit to one of $f_0$ , $f_0/2$ , $f_0/4$ , $f_0/8$ , $f_0/16$ , $f_0/32$ .<br>High impedance in standby mode | 328.5                            | 223.8  |
| 5       | VSS | -   | (-) ground                 | -   | -328.5                           | 223.8  |
| 6       | INH | I   | Output state control input | High impedance when LOW (oscillator stops).<br>Power-saving pull-up resistor built-in.  | -328.5                           | -5.0   |

## BLOCK DIAGRAM



\*1. N = 1, 2, 4, 8, 16, 32 (mask option)

\*2. 5041Axx version only

## ABSOLUTE MAXIMUM RATINGS

$V_{SS} = 0V$  unless otherwise noted.

| Parameter                               | Symbol    | Conditions           | Rating                 | Unit  |
|---|-----------|----------------------|------------------------|-------|
| Supply voltage range                    | $V_{DD}$  | Between VDD and VSS  | -0.3 to +4.0           | V     |
| Program read/write supply voltage range | $V_{PP}$  | Between INHN and VSS | -0.3 to +16.5          | V     |
| Input voltage range <sup>*1</sup>       | $V_{IN}$  | Input pins           | -0.3 to $V_{DD} + 0.3$ | V     |
| Output voltage range <sup>*1</sup>      | $V_{OUT}$ | Output pins          | -0.3 to $V_{DD} + 0.3$ | V     |
| Output current                          | $I_{OUT}$ | Q pin                | $\pm 20$               | mA    |
| Storage temperature range               | $T_{STG}$ | Wafer form           | -65 to +150            | °C    |
| EEPROM maximum writes                   | $N_{EW}$  |                      | 100                    | times |

\*1.  $V_{DD}$  is a  $V_{DD}$  value of recommended operating conditions.

Note. Absolute maximum ratings are the values that must never exceed even for a moment. This product may suffer breakdown if any one of these parameter ratings is exceeded. Operation and characteristics are guaranteed only when the product is operated at recommended supply voltage range.

## RECOMMENDED OPERATING CONDITIONS

$V_{SS} = 0V$  unless otherwise noted.

| Parameter                           | Symbol            | Conditions            |         | Rating <sup>*1</sup> |     |                 | Unit |
|-------------------------------------|-------------------|-----------------------|---------|----------------------|-----|-----------------|------|
|                                     |                   |                       |         | Min                  | Typ | Max             |      |
| Supply voltage                      | V <sub>DD</sub>   | Between VDD and VSS   | 5041A×× | 2.25                 | –   | 3.63            | V    |
|                                     |                   |                       | 5041B×A | 1.60                 | –   | 2.25            | V    |
| Input voltage                       | V <sub>IN</sub>   | Input pins (XT, INHN) |         | V <sub>SS</sub>      | –   | V <sub>DD</sub> | V    |
| Operating temperature               | T <sub>OPR</sub>  |                       |         | –40                  | –   | +85             | °C   |
| Oscillation frequency <sup>*2</sup> | fo                | 5041A××               |         | 20                   | –   | 55              | MHz  |
|                                     |                   | 5041B×A               |         | (20)                 | –   | (55)            | MHz  |
| Output frequency <sup>*2</sup>      | f <sub>OUT</sub>  | Q pin                 | 5041A×× | 0.625                | –   | 55              | MHz  |
|                                     |                   |                       | 5041B×A | (0.625)              | –   | (55)            | MHz  |
| Output load capacitance             | C <sub>LOUT</sub> | Q pin                 |         | –                    | –   | 15              | pF   |

\*1. Values in parentheses ( ) are provisional only.

\*2. The recommended oscillation frequency is a yardstick value derived from the crystal used for NPC characteristics authentication. However, the oscillation frequency range is not guaranteed. Specifically, the characteristics can vary greatly due to crystal characteristics and mounting conditions, so the oscillation characteristics of components must be carefully evaluated.

## ELECTRICAL CHARACTERISTICS

### DC Characteristics (5041A1× to A6×)

$V_{DD} = 2.25V$  to  $3.63V$ ,  $V_{SS} = 0V$ ,  $T_a = -40^{\circ}C$  to  $+85^{\circ}C$ ,  $C_{LOUT} = 15pF$  unless otherwise noted.

| Parameter  | Symbol    | Conditions   |                    | Rating       |     |             | Unit      |
|--|-----------|--|--------------------|--------------|-----|-------------|-----------|
|  |           |  |                    | MIN          | TYP | MAX         |           |
| Operating-mode current consumption <sup>*1</sup> | $I_{DD}$  | 5041A1× ( $f_{OUT} = f_o$ ),<br>Measurement circuit 1, no load,<br>INHN = HIGH, $f_o = 48MHz$    | $V_{DD} = 2.5V$    | –            | 1.4 | 2.8         | mA        |
|  |           |  | $V_{DD} = 3.3V$    | –            | 1.7 | 3.4         | mA        |
|  |           | 5041A2× ( $f_{OUT} = f_o/2$ ),<br>Measurement circuit 1, no load,<br>INHN = HIGH, $f_o = 48MHz$  | $V_{DD} = 2.5V$    | –            | 1.1 | 2.2         | mA        |
|  |           |  | $V_{DD} = 3.3V$    | –            | 1.4 | 2.7         | mA        |
|  |           | 5041A3× ( $f_{OUT} = f_o/4$ ),<br>Measurement circuit 1, no load,<br>INHN = HIGH, $f_o = 48MHz$  | $V_{DD} = 2.5V$    | –            | 1.0 | 1.9         | mA        |
|  |           |  | $V_{DD} = 3.3V$    | –            | 1.2 | 2.4         | mA        |
|  |           | 5041A4× ( $f_{OUT} = f_o/8$ ),<br>Measurement circuit 1, no load,<br>INHN = HIGH, $f_o = 48MHz$  | $V_{DD} = 2.5V$    | –            | 0.9 | 1.7         | mA        |
|  |           |  | $V_{DD} = 3.3V$    | –            | 1.0 | 2.1         | mA        |
|  |           | 5041A5× ( $f_{OUT} = f_o/16$ ),<br>Measurement circuit 1, no load,<br>INHN = HIGH, $f_o = 48MHz$ | $V_{DD} = 2.5V$    | –            | 0.8 | 1.7         | mA        |
|  |           |  | $V_{DD} = 3.3V$    | –            | 1.0 | 2.0         | mA        |
|  |           | 5041A6× ( $f_{OUT} = f_o/32$ ),<br>Measurement circuit 1, no load,<br>INHN = HIGH, $f_o = 48MHz$ | $V_{DD} = 2.5V$    | –            | 0.8 | 1.6         | mA        |
|  |           |  | $V_{DD} = 3.3V$    | –            | 1.0 | 2.0         | mA        |
| Standby-mode current consumption                 | $I_{ST}$  | Measurement circuit 1, INHN = LOW  |                    | –            | –   | 10          | $\mu A$   |
| HIGH-level output voltage                        | $V_{OH}$  | Q pin, Measurement circuit 3, $I_{OH} = -4mA$  |                    | $V_{DD}-0.4$ | –   | –           | V         |
| LOW-level output voltage                         | $V_{OL}$  | Q pin, Measurement circuit 3, $I_{OL} = 4mA$   |                    | –            | –   | 0.4         | V         |
| Output leakage current                           | $I_Z$     | Measurement circuit 4,<br>INHN = LOW   | $Q = V_{DD}$       | –            | –   | 10          | $\mu A$   |
|  |           |  | $Q = V_{SS}$       | –10          | –   | –           | $\mu A$   |
| HIGH-level input current                         | $V_{IH}$  | INHN pin, Measurement circuit 5  |                    | $0.7V_{DD}$  | –   | –           | V         |
| LOW-level input current                          | $V_{IL}$  |  |                    | –            | –   | $0.3V_{DD}$ | V         |
| INHN pull-up resistance                          | $R_{PU1}$ | Measurement circuit 6  | INHN = $V_{SS}$    | 0.4          | 1.5 | 10          | $M\Omega$ |
|  | $R_{PU2}$ |  | INHN = $0.7V_{DD}$ | 50           | 100 | 200         | $k\Omega$ |

\*1. The consumption current  $I_{DD}$  ( $C_{LOUT}$ ) with a load capacitance ( $C_{LOUT}$ ) connected to the Q pin is given by the following equation, where  $I_{DD}$  is the no-load consumption current and  $f_{OUT}$  is the output frequency.

$$I_{DD} (C_{LOUT}) [mA] = I_{DD} [mA] + C_{LOUT} [pF] \times V_{DD} [V] \times f_{OUT} [MHz] \times 10^{-3}$$

## DC Characteristics (5041B1A to B6A)

$V_{DD} = 1.60\text{V}$  to  $2.25\text{V}$ ,  $V_{SS} = 0\text{V}$ ,  $T_a = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $C_{LOUT} = 15\text{pF}$  unless otherwise noted.

| Parameter  | Symbol    | Conditions   | Rating             |     |             | Unit             |
|--|-----------|--|--------------------|-----|-------------|------------------|
|  |           |  | MIN                | TYP | MAX         |                  |
| Operating-mode current consumption <sup>*1</sup> | $I_{DD}$  | 5041B1A ( $f_{OUT} = f_o$ ), Measurement circuit 1, no load, INHN = HIGH, $f_o = 48\text{MHz}$ , $V_{DD} = 1.8\text{V}$    | –                  | 1.7 | 3.4         | mA               |
|  |           | 5041B2A ( $f_{OUT} = f_o/2$ ), Measurement circuit 1, no load, INHN = HIGH, $f_o = 48\text{MHz}$ , $V_{DD} = 1.8\text{V}$  | –                  | 1.5 | 3.3         | mA               |
|  |           | 5041B3A ( $f_{OUT} = f_o/4$ ), Measurement circuit 1, no load, INHN = HIGH, $f_o = 48\text{MHz}$ , $V_{DD} = 1.8\text{V}$  | –                  | 1.4 | 3.2         | mA               |
|  |           | 5041B4A ( $f_{OUT} = f_o/8$ ), Measurement circuit 1, no load, INHN = HIGH, $f_o = 48\text{MHz}$ , $V_{DD} = 1.8\text{V}$  | –                  | 1.4 | 3.1         | mA               |
|  |           | 5041B5A ( $f_{OUT} = f_o/16$ ), Measurement circuit 1, no load, INHN = HIGH, $f_o = 48\text{MHz}$ , $V_{DD} = 1.8\text{V}$ | –                  | 1.3 | 3.1         | mA               |
|  |           | 5041B6A ( $f_{OUT} = f_o/32$ ), Measurement circuit 1, no load, INHN = HIGH, $f_o = 48\text{MHz}$ , $V_{DD} = 1.8\text{V}$ | –                  | 1.3 | 3.0         | mA               |
| Standby-mode current consumption                 | $I_{ST}$  | Measurement circuit 1, INHN = LOW  | –                  | –   | 10          | $\mu\text{A}$    |
| HIGH-level output voltage                        | $V_{OH}$  | Q pin, Measurement circuit 3, $I_{OH} = -4\text{mA}$   | $V_{DD}-0.4$       | –   | –           | V                |
| LOW-level output voltage                         | $V_{OL}$  | Q pin, Measurement circuit 3, $I_{OL} = 4\text{mA}$  | –                  | –   | 0.4         | V                |
| Output leakage current                           | $I_Z$     | Measurement circuit 4, INHN = LOW  | Q = $V_{DD}$       | –   | 10          | $\mu\text{A}$    |
|  |           |  | Q = $V_{SS}$       | –10 | –           | $\mu\text{A}$    |
| HIGH-level input current                         | $V_{IH}$  | INHN pin, Measurement circuit 5  | $0.7V_{DD}$        | –   | –           | V                |
| LOW-level input current                          | $V_{IL}$  |  | –                  | –   | $0.3V_{DD}$ | V                |
| INHN pull-up resistance                          | $R_{PU1}$ | Measurement circuit 6  | INHN = $V_{SS}$    | 0.4 | 1.5         | $\text{M}\Omega$ |
|  | $R_{PU2}$ |  | INHN = $0.7V_{DD}$ | 50  | 100         | $\text{k}\Omega$ |

\*1. The consumption current  $I_{DD}$  ( $C_{LOUT}$ ) with a load capacitance ( $C_{LOUT}$ ) connected to the Q pin is given by the following equation, where  $I_{DD}$  is the no-load consumption current and  $f_{OUT}$  is the output frequency.

$$I_{DD}(C_{LOUT}) [\text{mA}] = I_{DD} [\text{mA}] + C_{LOUT} [\text{pF}] \times V_{DD} [\text{V}] \times f_{OUT} [\text{MHz}] \times 10^{-3}$$

## AC Characteristics

### Clock output characteristics (5041A1× to A6×, Q pin)

$V_{DD} = 2.25V$  to  $3.63V$ ,  $V_{SS} = 0V$ ,  $T_a = -40^{\circ}C$  to  $+85^{\circ}C$ ,  $C_{LOUT} = 15pF$  unless otherwise noted.

| Parameter                       | Symbol   | Conditions  | Rating |     |     | Unit |
|---------------------------------|----------|---|--------|-----|-----|------|
|                                 |          |   | MIN    | TYP | MAX |      |
| Output rise time                | $t_r$    | Measurement circuit 1, $0.1V_{DD} \rightarrow 0.9V_{DD}$                            | —      | —   | 4.5 | ns   |
| Output fall time                | $t_f$    | Measurement circuit 1, $0.9V_{DD} \rightarrow 0.1V_{DD}$                            | —      | —   | 4.5 | ns   |
| Output duty cycle <sup>*1</sup> | Duty     | Measurement circuit 1, threshold voltage $0.5V_{DD}$ ,<br>Duty = $T_w/T \times 100$ | 45     | 50  | 55  | %    |
| Output disable delay time       | $t_{OD}$ | Measurement circuit 2, INHN = HIGH $\rightarrow$ LOW                                | —      | —   | 100 | ns   |

\*1. This parameter is measured using the NPC's standard crystal. Note that the values will vary with the crystal characteristics used or mounting conditions.

### Clock output characteristics (5041B1A to B6A, Q pin)

$V_{DD} = 1.60V$  to  $2.25V$ ,  $V_{SS} = 0V$ ,  $T_a = -40^{\circ}C$  to  $+85^{\circ}C$ ,  $C_{LOUT} = 15pF$  unless otherwise noted.

| Parameter                       | Symbol   | Conditions  | Rating <sup>*1</sup> |      |      | Unit |
|---------------------------------|----------|---|----------------------|------|------|------|
|                                 |          |   | MIN                  | TYP  | MAX  |      |
| Output rise time                | $t_r$    | Measurement circuit 1, $0.1V_{DD} \rightarrow 0.9V_{DD}$                            | —                    | —    | 5    | ns   |
| Output fall time                | $t_f$    | Measurement circuit 1, $0.9V_{DD} \rightarrow 0.1V_{DD}$                            | —                    | —    | 5    | ns   |
| Output duty cycle <sup>*2</sup> | Duty     | Measurement circuit 1, threshold voltage $0.5V_{DD}$ ,<br>Duty = $T_w/T \times 100$ | (45)                 | (50) | (55) | %    |
| Output disable delay time       | $t_{OD}$ | Measurement circuit 2, INHN = HIGH $\rightarrow$ LOW                                | —                    | —    | 100  | ns   |

\*1. Values in parentheses ( ) are provisional only.

\*2. This parameter is measured using the NPC's standard crystal. Note that the values will vary with the crystal characteristics used or mounting conditions.

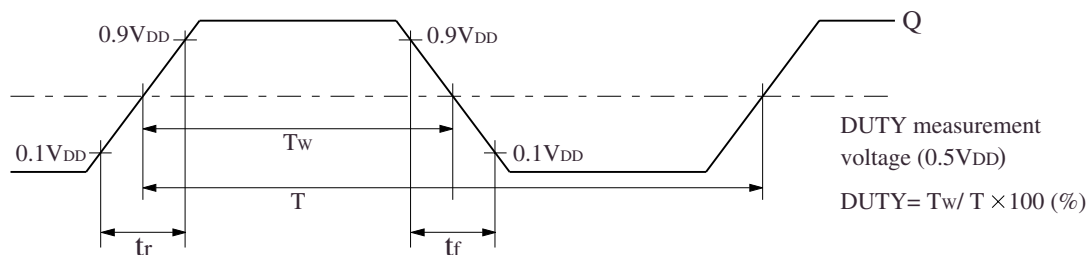
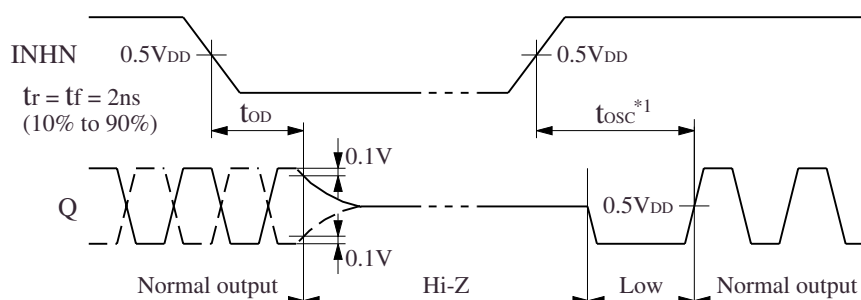


Figure 1. Output switching waveform



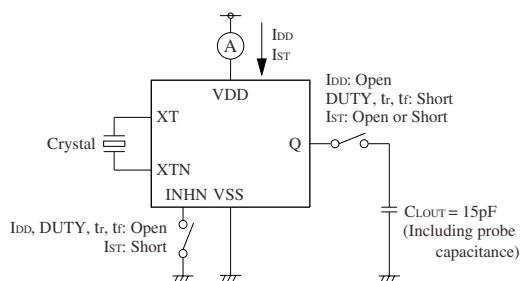
\*1.  $t_{OSC}$  is oscillator start-up time. It is interval of time until the oscillation is stabilized and varies with the crystal used.  
Please contact us for further details.

Figure 2. Output disable timing chart

## MEASUREMENT CIRCUITS

### Measurement Circuit 1

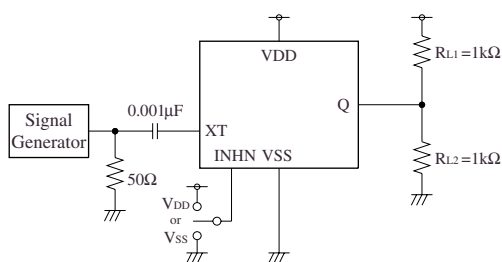
Parameters:  $I_{DD}$ ,  $I_{ST}$ , Duty,  $t_r$ ,  $t_f$



Note: The AC characteristics are observed using an oscilloscope on pin Q.

### Measurement Circuit 2

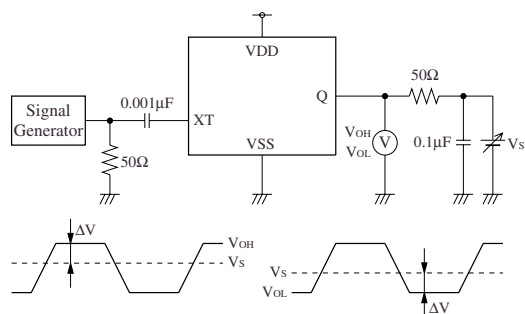
Parameters:  $t_{OD}$



XT input signal: 1Vp-p, sine wave

### Measurement Circuit 3

Parameters:  $V_{OH}$ ,  $V_{OL}$



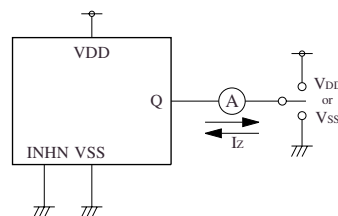
$V_S$  adjusted such that  $\Delta V = 50 \times I_{OH}$ .

$V_S$  adjusted such that  $\Delta V = 50 \times I_{OL}$ .

XT input signal: 1Vp-p, sine wave

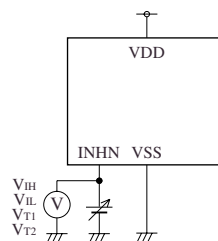
### Measurement Circuit 4

Parameters:  $I_Z$



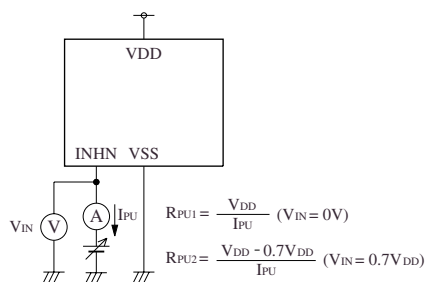
### Measurement Circuit 5

Parameters:  $V_{IH}$ ,  $V_{IL}$



### Measurement Circuit 6

Parameters:  $R_{PU1}$ ,  $R_{PU2}$





## FUNCTIONAL DESCRIPTION

### Frequency Adjustment Function

The 5041 series ICs have a built-in oscillator frequency adjustment function. The frequency adjustment settings are written to and stored in internal EEPROM, making the devices easy to setup. A typical compensation sequence is shown below.

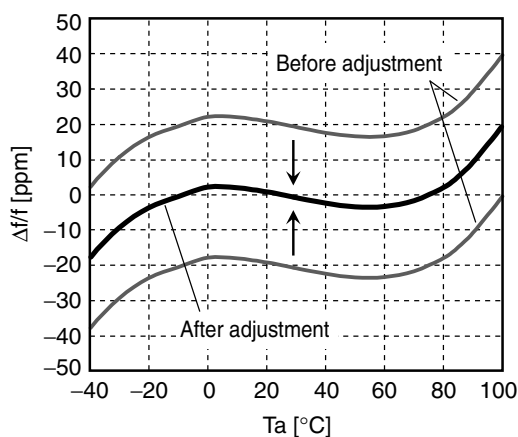


Figure 3. Center frequency adjustment

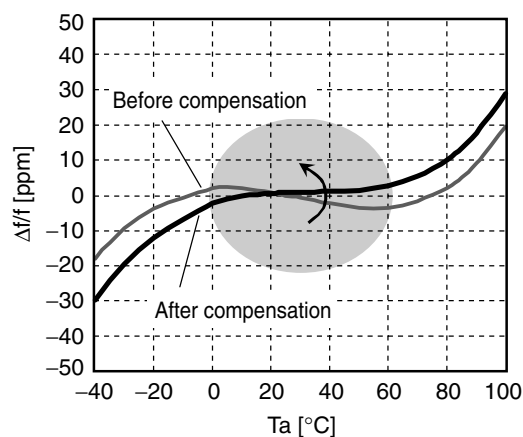


Figure 4. Temperature rotation compensation

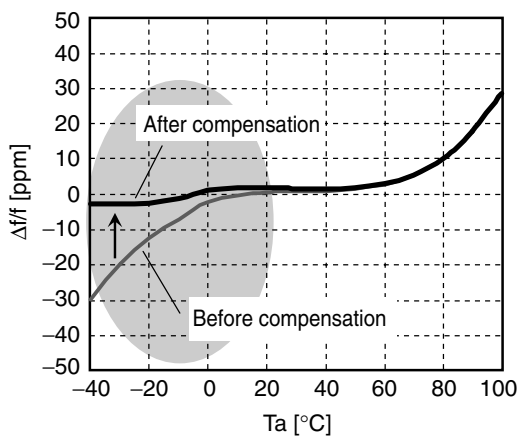


Figure 5. Low-temperature characteristics compensation

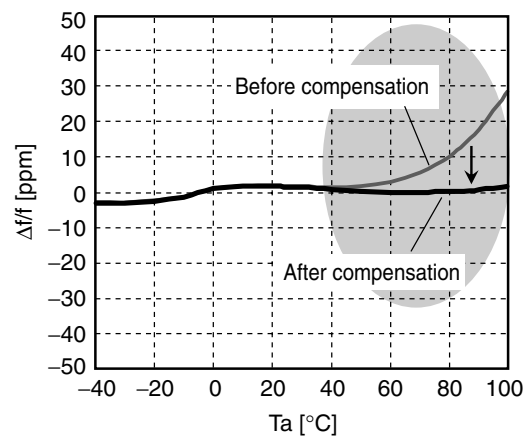


Figure 6. High-temperature characteristics compensation

### **Power-saving Pull-up Resistor**

The INHN pin pull-up resistance  $R_{PU1}$  or  $R_{PU2}$  changes in response to the input level (open, HIGH, or LOW). When INHN is tied LOW level, the pull-up resistance is large ( $R_{PU1}$ ), reducing the current consumed by the resistance. When INHN is left open circuit (HIGH), the pull-up resistance is small ( $R_{PU2}$ ), which increases the input susceptibility to external noise. However, the pull-up resistance ties the INHN pin HIGH level to prevent external noise from unexpectedly stopping the output.

### **Oscillation Detector Function**

The 5041 series also feature an oscillation detector circuit. This circuit functions to disable the outputs until the oscillator circuit starts and oscillation becomes stable. This alleviates the danger of abnormal oscillator output at oscillator start-up when power is applied or when INHN is switched.

Please pay your attention to the following points at time of using the products shown in this document.

1. The products shown in this catalog (hereinafter "Products") are not designed and manufactured to be used for the apparatus that exerts harmful influence on the human lives due to the defects, failure or malfunction of the Products. If you wish to use the Products in that apparatus, please contact our sales section in advance.  
In the event that the Products are used in such apparatus without our prior approval, we assume no responsibility whatsoever for any damages resulting from the use of that apparatus.
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